

MOS FIELD EFFECT TRANSISTOR

2SJ607

SWITCHING

P-CHANNEL POWER MOS FET

DESCRIPTION

The 2SJ607 is P-channel MOS Field Effect Transistor designed for high current switching applications.

FEATURES

- Super low on-state resistance:
 - $R_{DS(on)1} = 11 \text{ m}\Omega \text{ MAX. (} V_{GS} = -10 \text{ V, } I_D = -42 \text{ A)}$
 - $R_{DS(on)2} = 16 \text{ m}\Omega \text{ MAX. (} V_{GS} = -4.0 \text{ V, } I_D = -42 \text{ A)}$
- Low input capacitance:
 - $C_{iss} = 7500 \text{ pF TYP. (} V_{DS} = -10 \text{ V, } V_{GS} = 0 \text{ V)}$
- Built-in gate protection diode

ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$)

Drain to Source Voltage ($V_{GS} = 0 \text{ V}$)	V_{DS}	-60	V
Gate to Source Voltage ($V_{DS} = 0 \text{ V}$)	V_{GS}	∓ 20	V
Drain Current (DC) ($T_C = 25^\circ\text{C}$)	$I_{D(DC)}$	∓ 83	A
Drain Current (pulse) ^{Note1}	$I_{D(pulse)}$	∓ 332	A
Total Power Dissipation ($T_C = 25^\circ\text{C}$)	P_T	160	W
Total Power Dissipation ($T_A = 25^\circ\text{C}$)	P_T	1.5	W
Channel Temperature	T_{ch}	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 to +150	$^\circ\text{C}$
Single Avalanche Current ^{Note2}	I_{AS}	-50	A
Single Avalanche Energy ^{Note2}	E_{AS}	250	mJ

Notes 1. $PW \leq 10 \mu\text{s}$, Duty cycle $\leq 1\%$

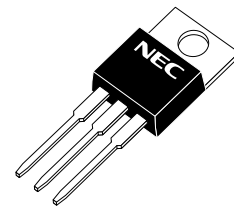
2. Starting $T_{ch} = 25^\circ\text{C}$, $V_{DD} = -30 \text{ V}$, $R_G = 25 \Omega$, $V_{GS} = -20 \rightarrow 0 \text{ V}$

ORDERING INFORMATION

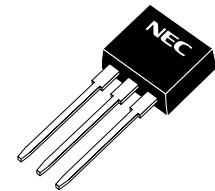
PART NUMBER	PACKAGE
2SJ607	TO-220AB
2SJ607-S	TO-262
2SJ607-ZJ	TO-263
2SJ607-Z	TO-220SMD ^{Note}

Note TO-220SMD package is produced only in Japan

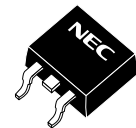
(TO-220AB)



(TO-262)



(TO-263, TO-220SMD)

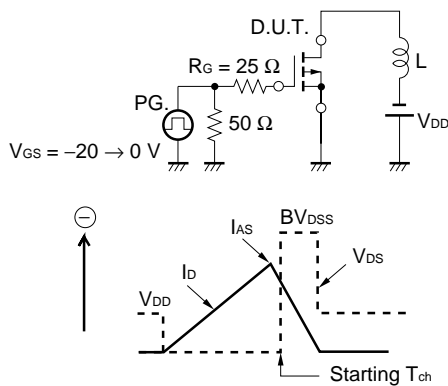


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 Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.

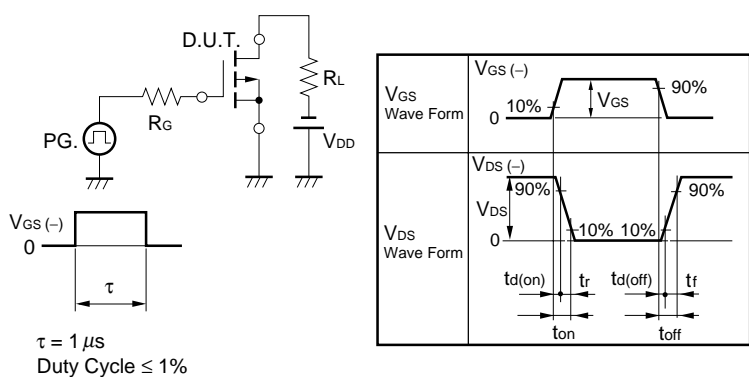
ELECTRICAL CHARACTERISTICS (T_A = 25°C)

CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = -60 V, V _{GS} = 0 V			-10	μA
Gate Leakage Current	I _{GSS}	V _{GS} = ±20 V, V _{DS} = 0 V			±10	μA
Gate Cut-off Voltage	V _{GS(off)}	V _{DS} = -10 V, I _D = -1 mA	-1.5	-2.0	-2.5	V
Forward Transfer Admittance	y _{fs}	V _{DS} = -10 V, I _D = -42 A	45	90		S
Drain to Source On-state Resistance	R _{DS(on)1}	V _{GS} = -10 V, I _D = -42 A		9.1	11	mΩ
	R _{DS(on)2}	V _{GS} = -4.0 V, I _D = -42 A		11	16	mΩ
Input Capacitance	C _{iss}	V _{DS} = -10 V		7500		pF
Output Capacitance	C _{oss}	V _{GS} = 0 V		1800		pF
Reverse Transfer Capacitance	C _{rss}	f = 1 MHz		430		pF
Turn-on Delay Time	t _{d(on)}	V _{DD} = -30 V, I _D = -42 A		23		ns
Rise Time	t _r	V _{GS} = -10 V		16		ns
Turn-off Delay Time	t _{d(off)}	R _G = 0 Ω		340		ns
Fall Time	t _f			160		ns
Total Gate Charge	Q _G	V _{DD} = -48 V		188		nC
Gate to Source Charge	Q _{GS}	V _{GS} = -10 V		30		nC
Gate to Drain Charge	Q _{GD}	I _D = -83 A		48		nC
Body Diode Forward Voltage	V _{F(S-D)}	I _F = 83 A, V _{GS} = 0 V		1.0		V
Reverse Recovery Time	t _{rr}	I _F = 83 A, V _{GS} = 0 V		64		ns
Reverse Recovery Charge	Q _{rr}	di/dt = 100 A/μs		150		nC

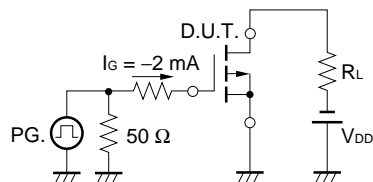
TEST CIRCUIT 1 AVALANCHE CAPABILITY



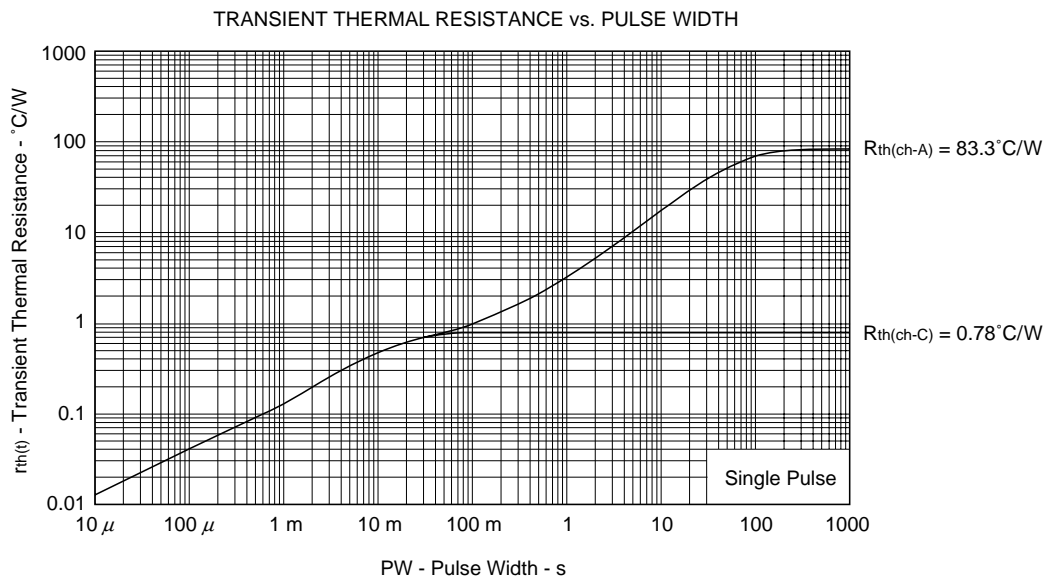
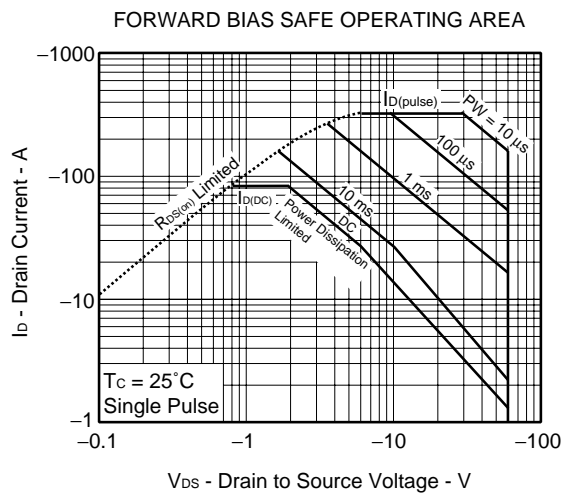
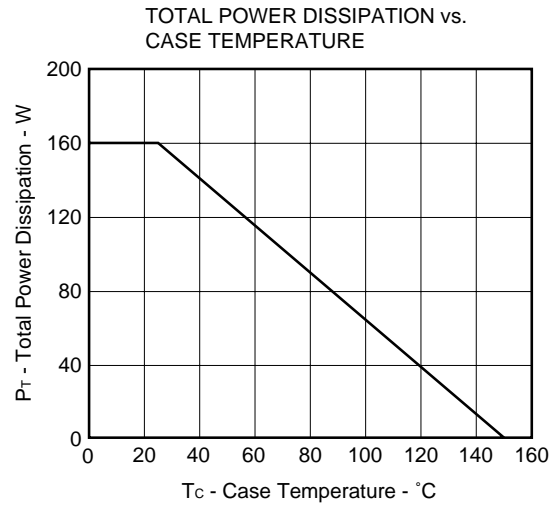
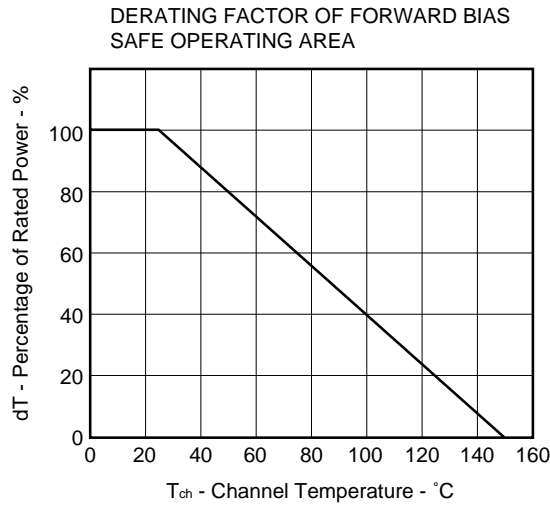
TEST CIRCUIT 2 SWITCHING TIME



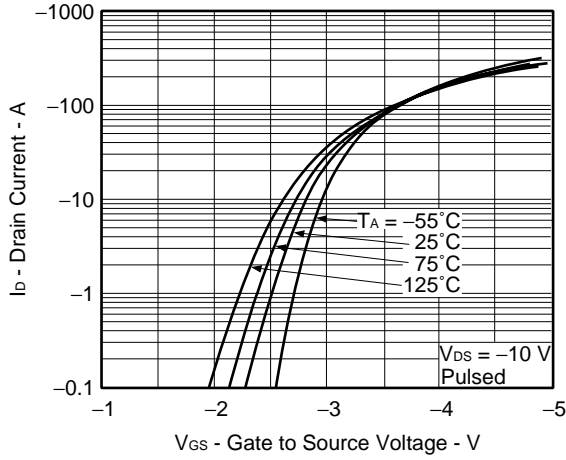
TEST CIRCUIT 3 GATE CHARGE



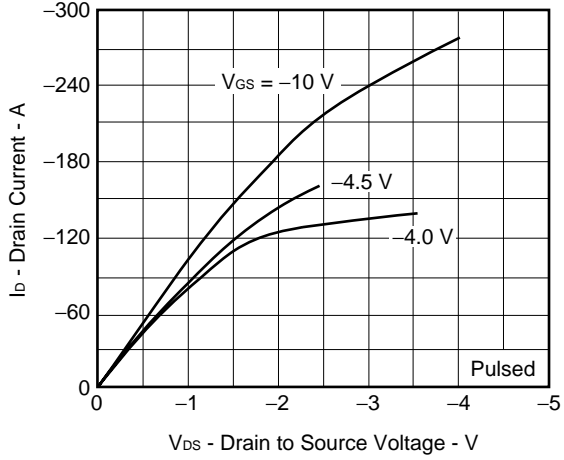
TYPICAL CHARACTERISTICS (T_A = 25°C)



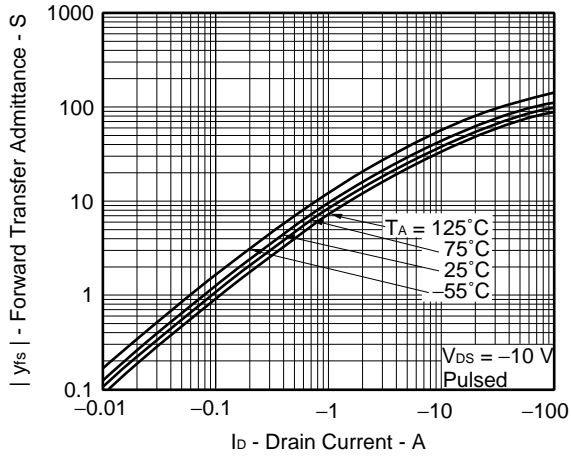
FORWARD TRANSFER CHARACTERISTICS



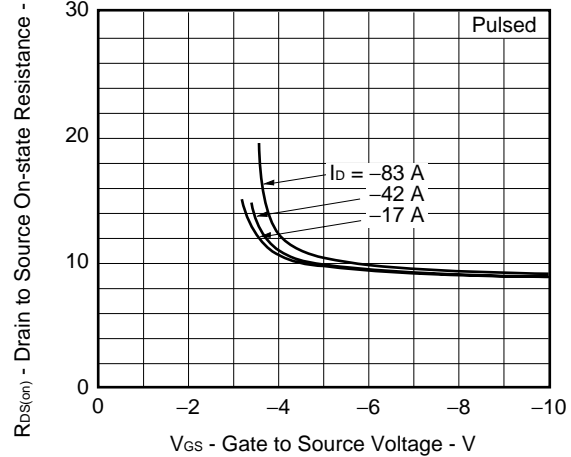
DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



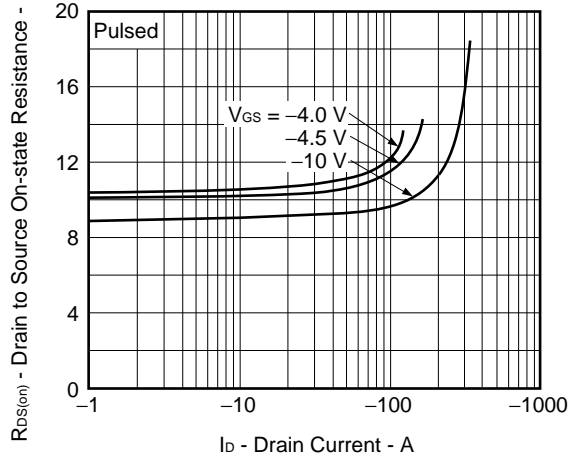
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



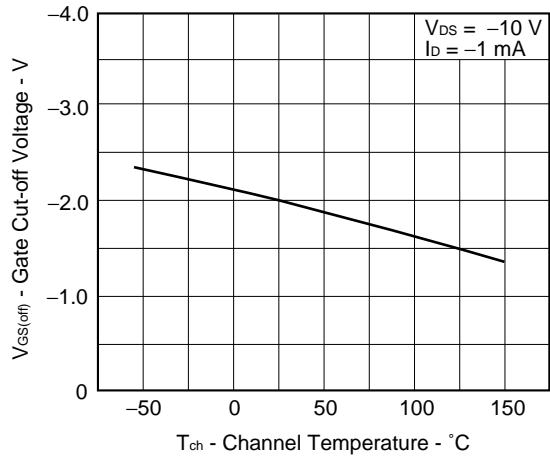
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



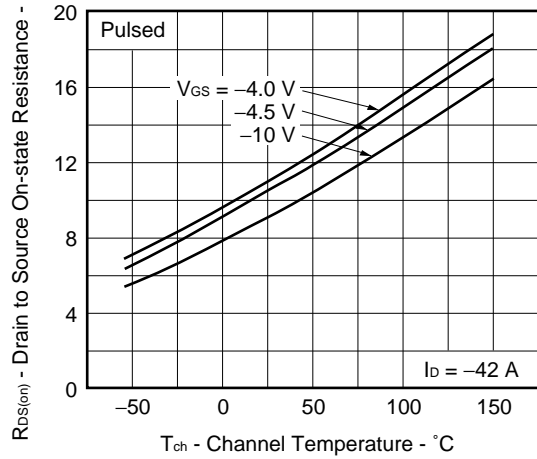
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



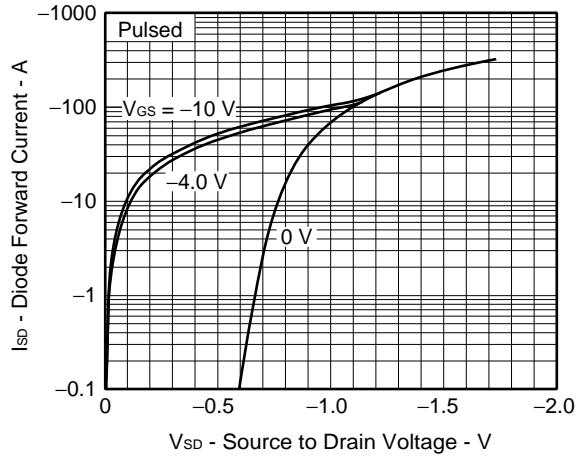
GATE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE



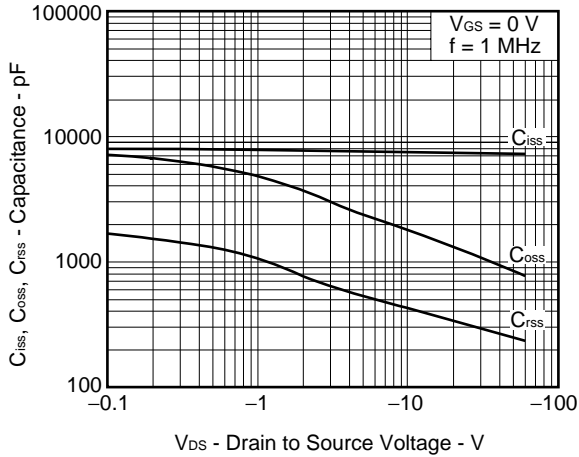
DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE



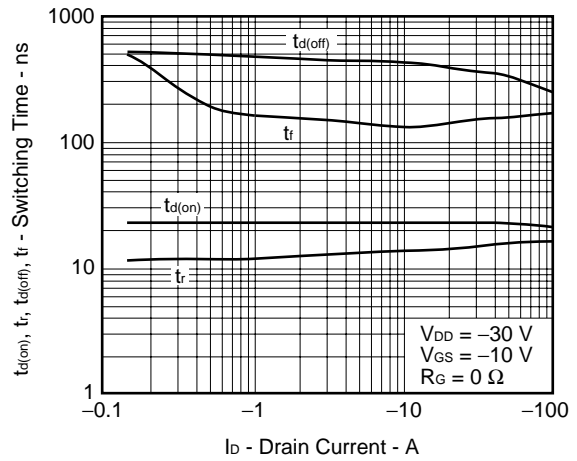
SOURCE TO DRAIN DIODE FORWARD VOLTAGE



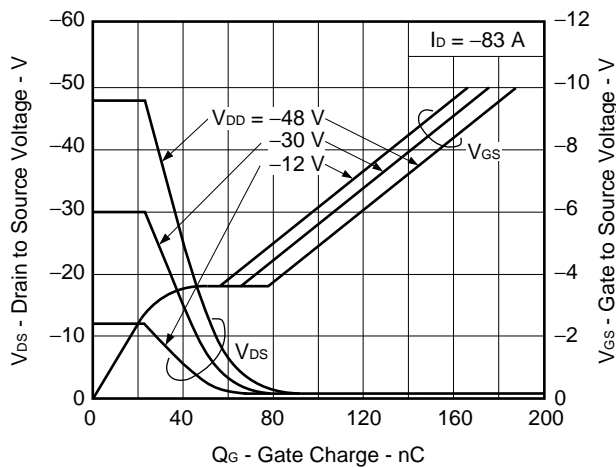
CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE



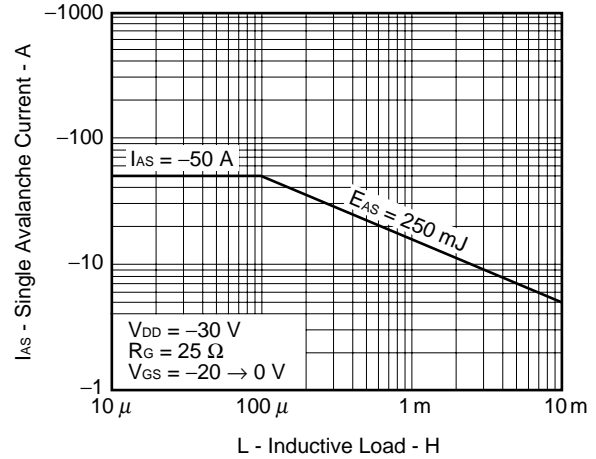
SWITCHING CHARACTERISTICS

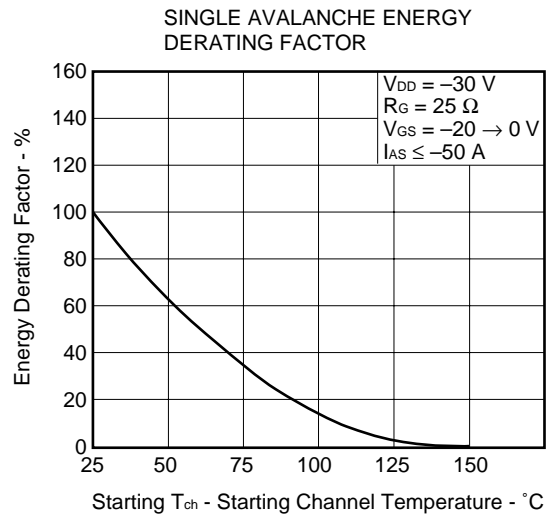


DYNAMIC INPUT/OUTPUT CHARACTERISTICS



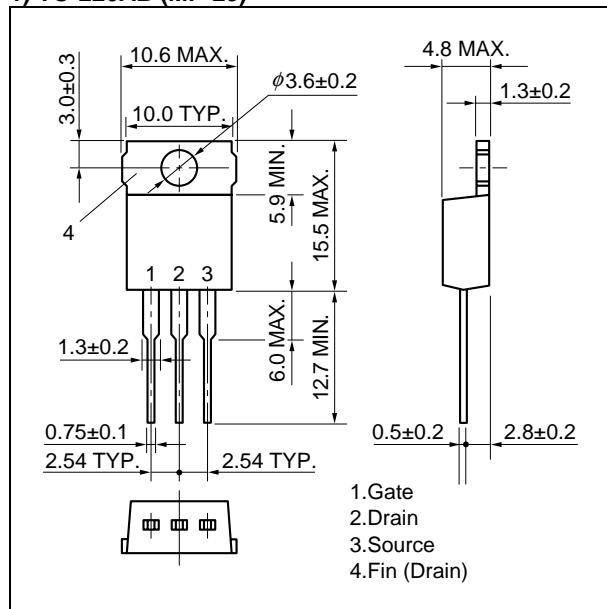
SINGLE AVALANCHE CURRENT vs. INDUCTIVE LOAD



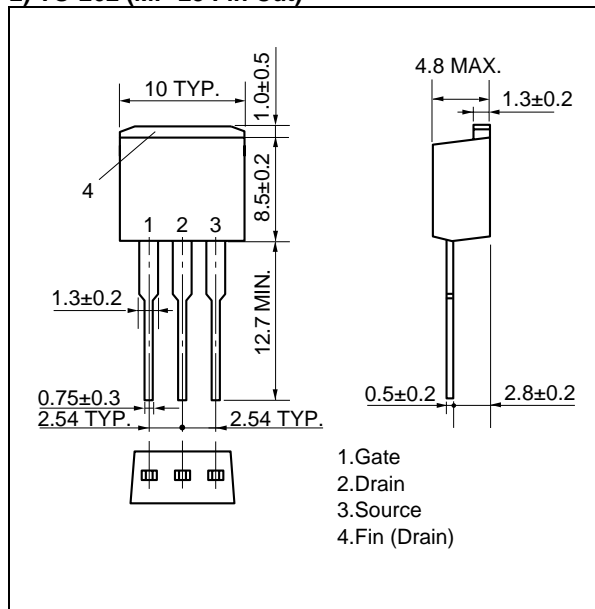


★ PACKAGE DRAWINGS (Unit: mm)

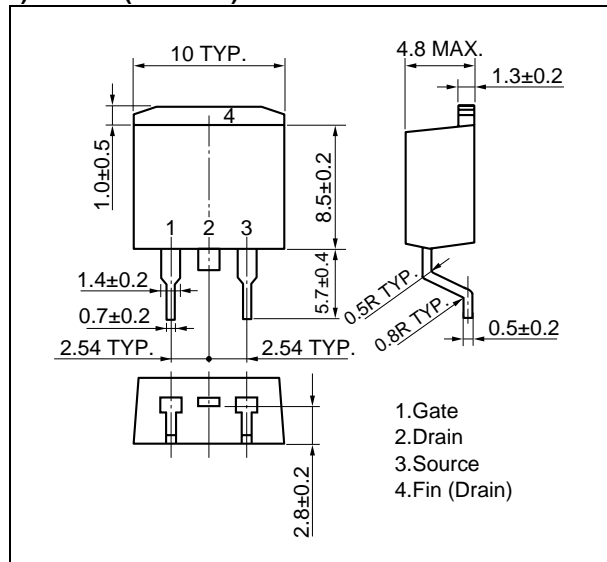
1) TO-220AB (MP-25)



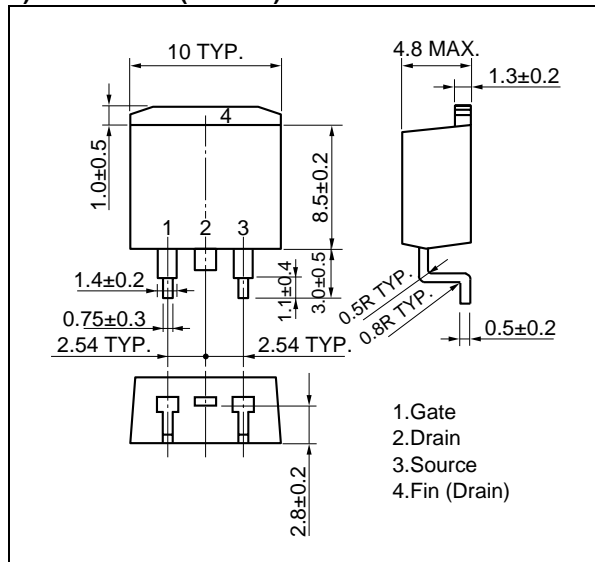
2) TO-262 (MP-25 Fin Cut)



3) TO-263 (MP-25ZJ)

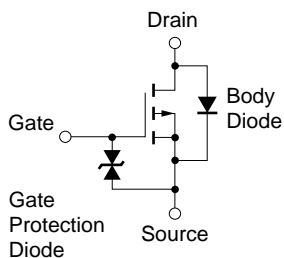


4) TO-220SMD (MP-25Z) ^{Note}



Note This package is produced only in Japan.

EQUIVALENT CIRCUIT



Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.